NISS

Microdata Tool Kit: Prospectus

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Background: Current NISS research on SDL for numerical microdata

- 8 methods, each with "settable parameters"
 - Rank swapping
 - Resampling
 - Addition of noise
 - 5 forms of microaggregation
- · 3 utility measures
 - KL distance between original and masked data
 - Confidence ellipse for a single regression
 - Confidence intervals for a single regression
- 2 disclosure risk measures
 - % of correctly linked records
 - % of correctly linked records, weighted by distance

What Would the MDTK Do?

- Computational experiments similar to—but more complicated than—those done by the DSTK
 - User selects
 - · Methods and one or more parameter values for each
 - Utility measure(s)
 - Risk measure(s)
 - MDTK
 - · Computes risk and utility measures
 - · Calculates frontier
 - · Visualizes results

How Would it Be Structured

- Modular and extensible, to allow "plug in" of
 - New SDL methods
 - New risk measures
 - New utility measures
- Like DSTK, consisting of engines run by script (specs) files that can be generated
 - Manually
 - Via GUI

What Would it Take?

- Good code in place for
 - SDL methods
 - Existing risk and utility methods
- Big issue is the extensibility (APIs, data structures, inter-component communication, ...)
- High-end approach

 Right professional programmer working 4-6 months
- · More modest approach
 - Professional software architect to create core
 - Student programmers to do GUIs, viz, ...

The "Trailer"

- Some combinations of methods work better than either component method alone
 - Example: Micmul03 followed by noise_70
 - ~3X reduction in KL data distortion compared to Micmul03 alone
 - >25X reduction in disclosure risk compared to Micmul03 alone
- So, MDTK might also allow combinations!